

Application/Contr I N .	Applicant(s)/Patent und r R examination
10/511,569	DIAO ET AL.
Examiner	Art Unit
Bobbak Safaipour	2631

	SEARCHED				
Class	Subclass	Date	Examiner		

INT	ERFERENC	RFERENCE SEARCHED		
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, IBM_TDB (see attached search strategy)	9/11/2006	BS		
Consulted during QEM Meeting	9/11/2006	BS		
Consulted with Lewis West	9/11/2006	BS		
Consulted with Rafael Perez-Gutierrez	9/11/2006	BS		